

Search Notes

Application/Control No.

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Examiner

David J. Blanchard

Applicant(s)/Patent under
Reexamination

PASTAN ET AL.

Art Unit

1643

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
SEQ ID Nos:1, 13, 14, 28, 29, 40 and 41		7/15/2008	DB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC search SEQ ID Nos:1, 13, 14, 28, 29, 40 and 41 (results in SCORE)	7/15/2008	DB
Inventor search in PALM	7/14/2008	DB